

**Notice of References Cited**

Application/Control No.

10/805,925

Applicant(s)/Patent Under  
Reexamination  
LANDERS ET AL.

Examiner

Ayal I. Sharon

Art Unit

2123

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Han, JungHyun and Aristides Requicha. "Feature Recognition from CAD Models." IEEE Computer Graphics and Applications. March/April 1998. pp.80-94.
	V	Han, Jung Hyun et al. "Manufacturing Feature Recognition Toward Integration with Process Planning." IEEE Transactions on Systems, Man, and Cybernetics. June 2001. Vol.31, No.3. pp.373-380
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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